IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re PATENT APPLICATION of

UEMURA et al.

Appln. No.: 08/866,129

Filed: May 30, 1997

Group: 2814

Examiner: D. Willie

Title: DEVICES RELATED TO ELECTRODE PADS FOR P-TYPE GROUP III NITRIDE COMPOUND SEMICONDUCTORS

SEP 2 0 2000

Date: September 20, 2000

FILING OF SUPPLEMENTAL DECLARATION

Hon. Commissioner of Patents and Trademarks Washington, DC 20231

Sir:

Please accept the Supplemental Declaration, which is attached hereto for the above-identified application.

Respectfully submitted,

PILLSBURY MADISON & SUTRO LLP

Senlott. alta 30,368

By:_

Atty: Peter W. Gowdey

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PWG/VPH:ksh Attachment

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Group Art Unit: 2814

Filed: May 30, 1997

Examiner: D. Willie

For: DEVICES RELATED TO ELECTRODE PADS FOR P-TYPE GROUP III NITRIDE COMPOUND SEMICONDUCTORS



DECLARATION UNDER 37 C.F.R. § 1.132

Hon. Commissioner of Patents and Trademarks Washington, D.C. 2023

Sir:

We, Toshiya UEMURA, Naoki SHIBATA, Shizuyo NOIRI, and Shigemi HORIUCHI, hereby declare that:

- 1. We are the named and true inventors of the above-captioned patent application, we are co-inventors of the subject matter disclosed and claimed in the patent application, and we are the only inventors thereof.
- 2. We have reviewed and are familiar with the claims and disclosure of the patent application.
- 3. We have reviewed and are familiar with the Office Action of April 11, 2000 and Advisory Action of May 5, 2000.
- 4. We have reviewed the accuracy of the experimental data and clarifying information set forth in the graphs attached hereto. The experimental data set forth in the attached graphs A-1, A-2L, A-2S, A-3, A-4 and A-5 was collected based on experiments



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performed by us or performed under our supervision. The heat treatment of the samples was conducted at a temperature of 570°C for three (3) minutes. The experimental data set forth in the attached graphs are identical to that previously submitted. The attached graphs have been have been submitted for the purpose of including clarifying information on the x-axes to better characterize the inversion process of Au and Ni layers during heat treatment in an oxidative environment, and non-inversion of Ni and Au when during heat treatment in a nonoxidative environment. This information was requested by the Examiner in the April 11, 2000 final Office Action

We further declare that all statements made of our knowledge are true, and 5. that all statements were made with the knowledge that willful false statements and the like so made are punishable by tine and/or imprisonment under Section 1001 of Title 18 of the United States Code, and may jeopardize the validity of the application or any patent issuing therefrom.

Toshiya Venusa	31/18/2000
Toshiya UEMURA	Date
Maoki Slibala	3/108/2000
Naoki SHIBATA	Date
Shizuyo Noiri	01/09/2000
Sizuyo NOIRI	Date
Shigemi Horinchi	3// 18/2000
Shigemi HORIUCHI	Date